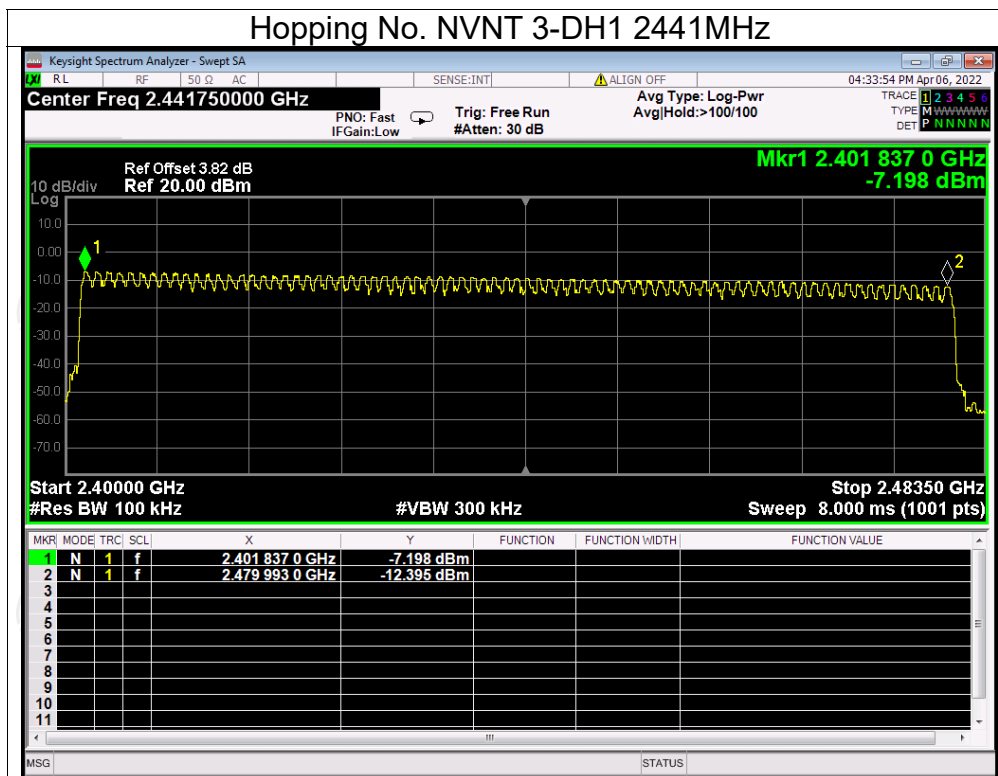


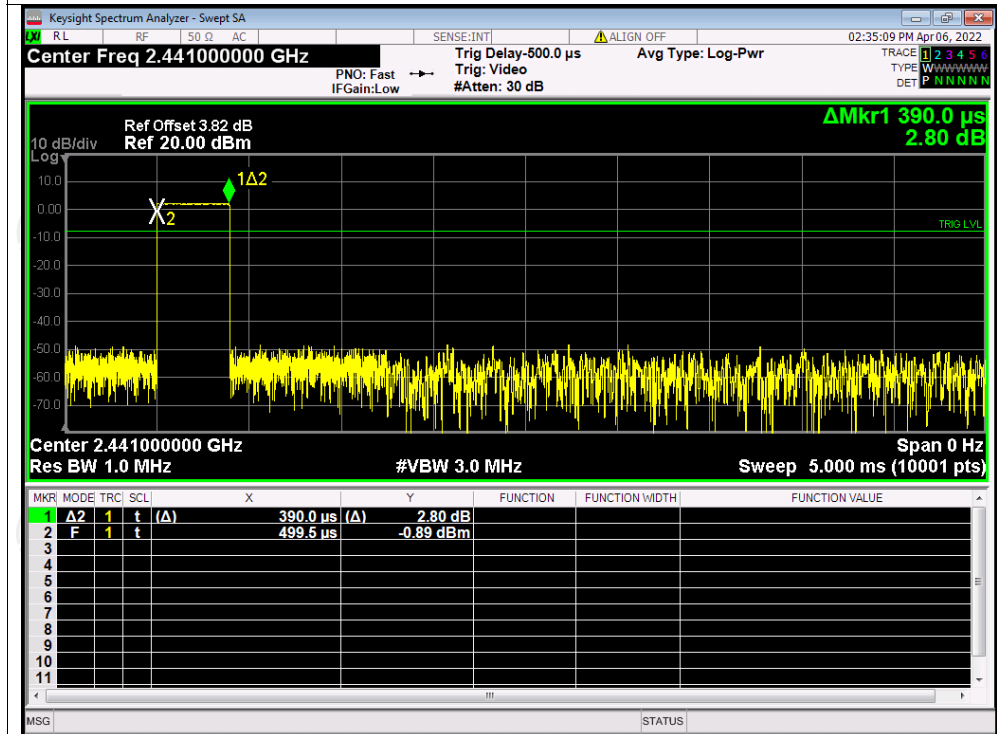


Dwell Time

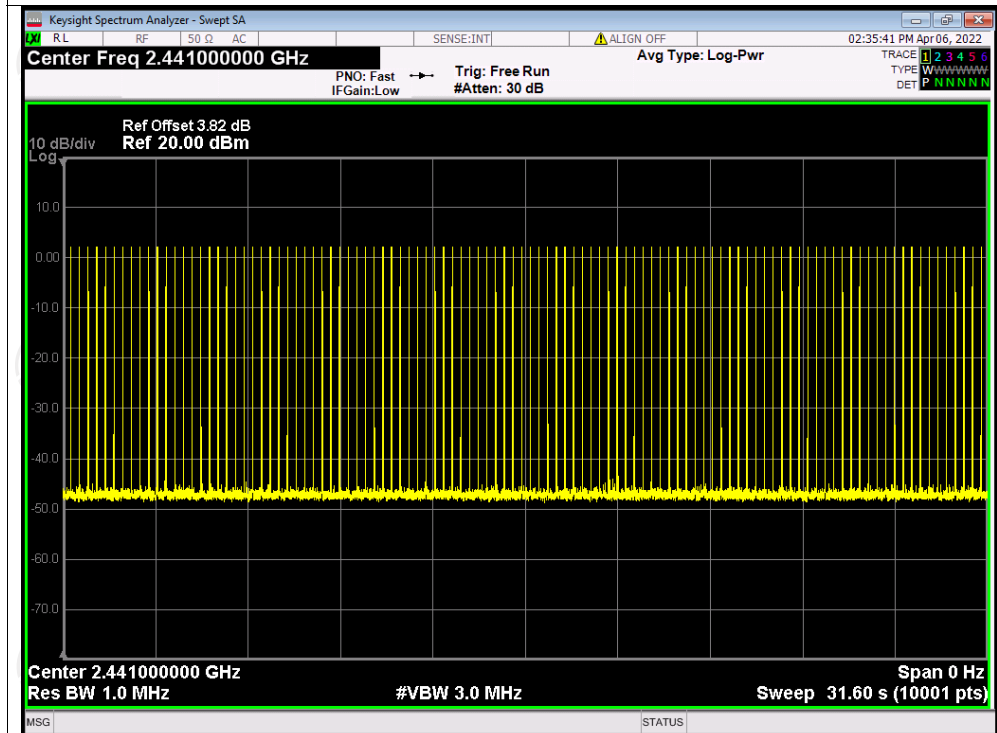
Condition	Mode	Frequency (MHz)	Pulse Time (ms)	Total Dwell Time (ms)	Burst Count	Period Time (ms)	Limit (ms)	Verdict
NVNT	1-DH1	2441	0.39	41.34	106	31600	400	Pass
NVNT	1-DH3	2441	1.65	176.55	107	31600	400	Pass
NVNT	1-DH5	2441	2.90	310.30	107	31600	400	Pass
NVNT	2-DH1	2441	0.40	42.80	107	31600	400	Pass
NVNT	2-DH3	2441	1.63	174.41	107	31600	400	Pass
NVNT	2-DH5	2441	2.88	308.16	107	31600	400	Pass
NVNT	3-DH1	2441	0.40	42.80	107	31600	400	Pass
NVNT	3-DH3	2441	1.62	173.34	107	31600	400	Pass
NVNT	3-DH5	2441	2.87	307.09	107	31600	400	Pass

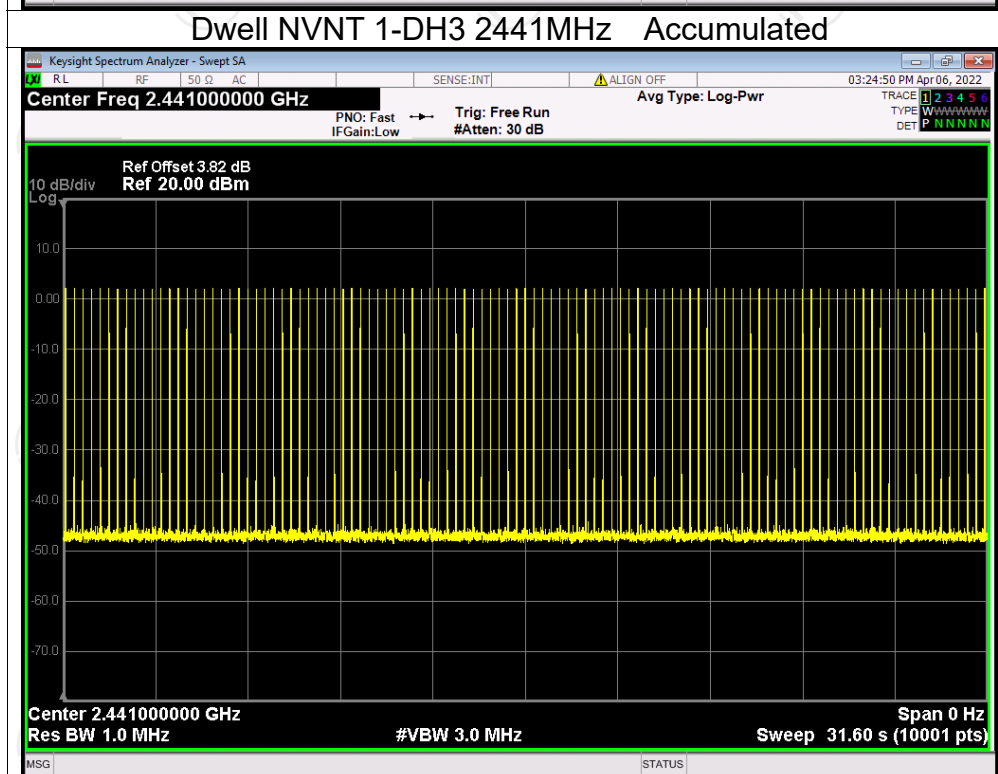
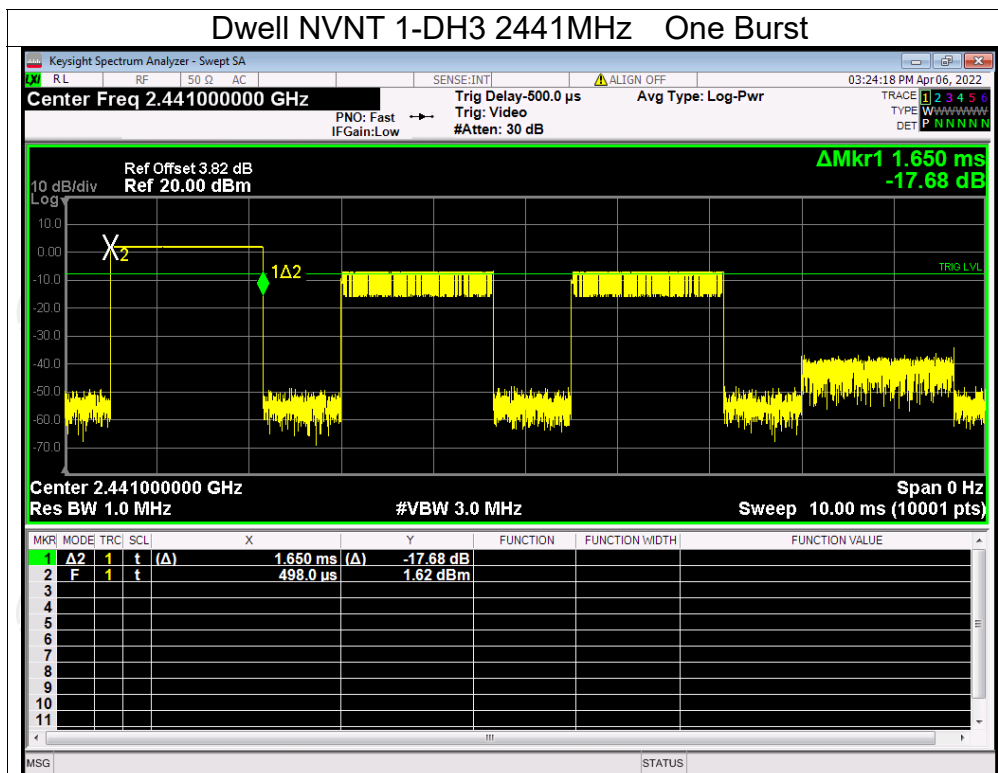
Test Graphs

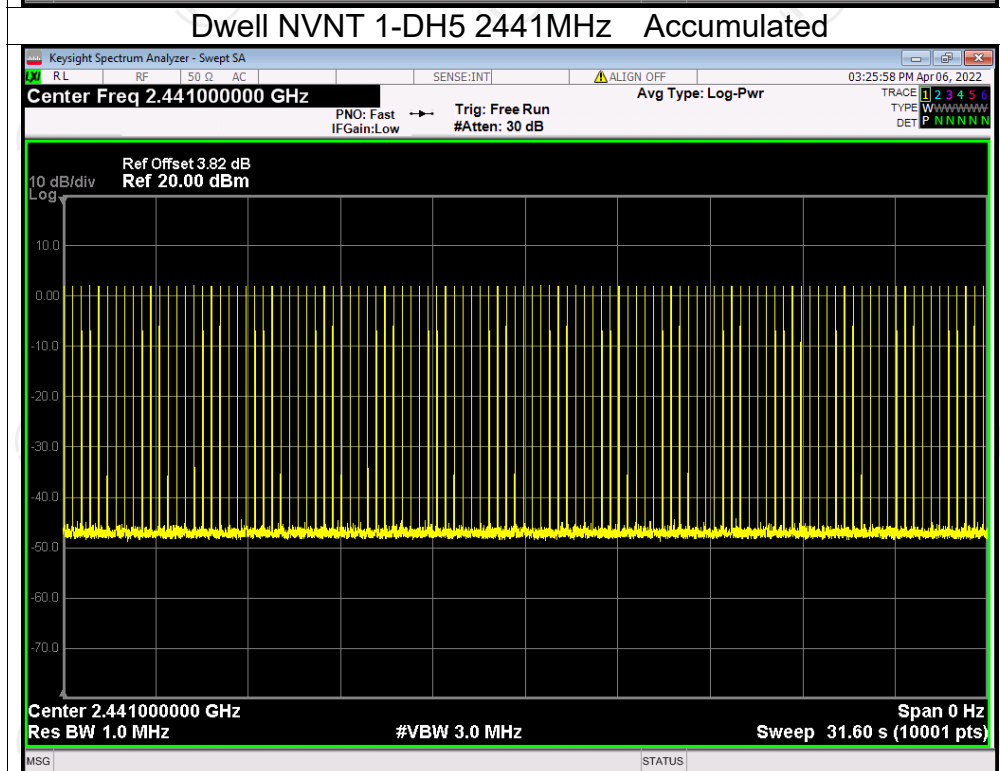
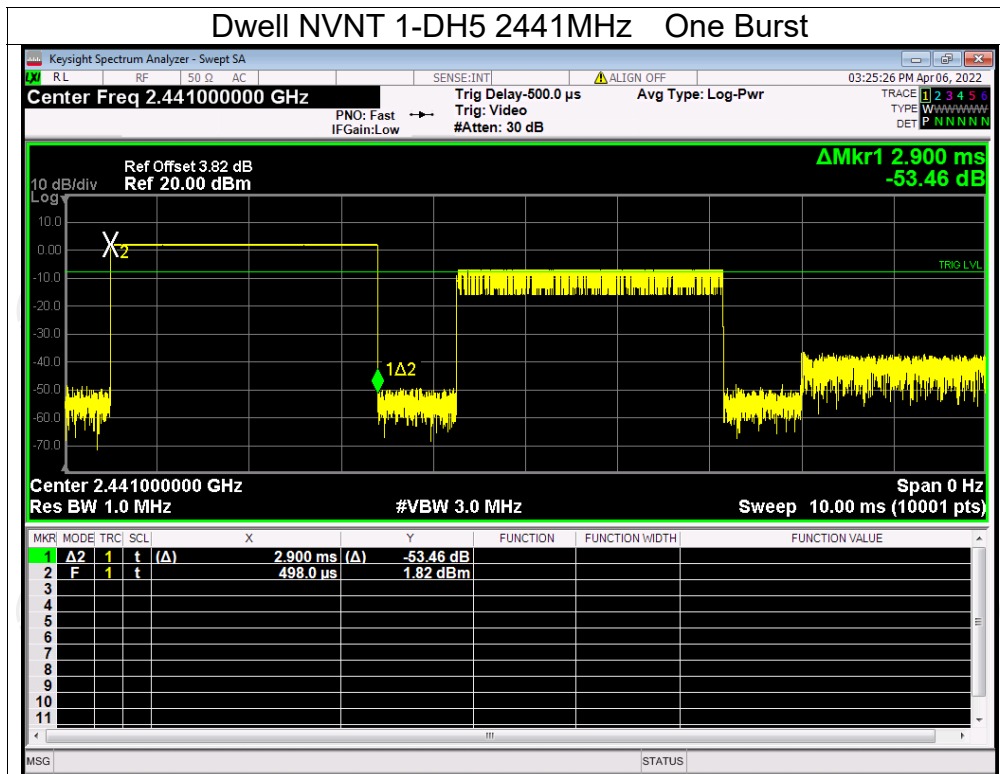
Dwell NVNT 1-DH1 2441MHz One Burst

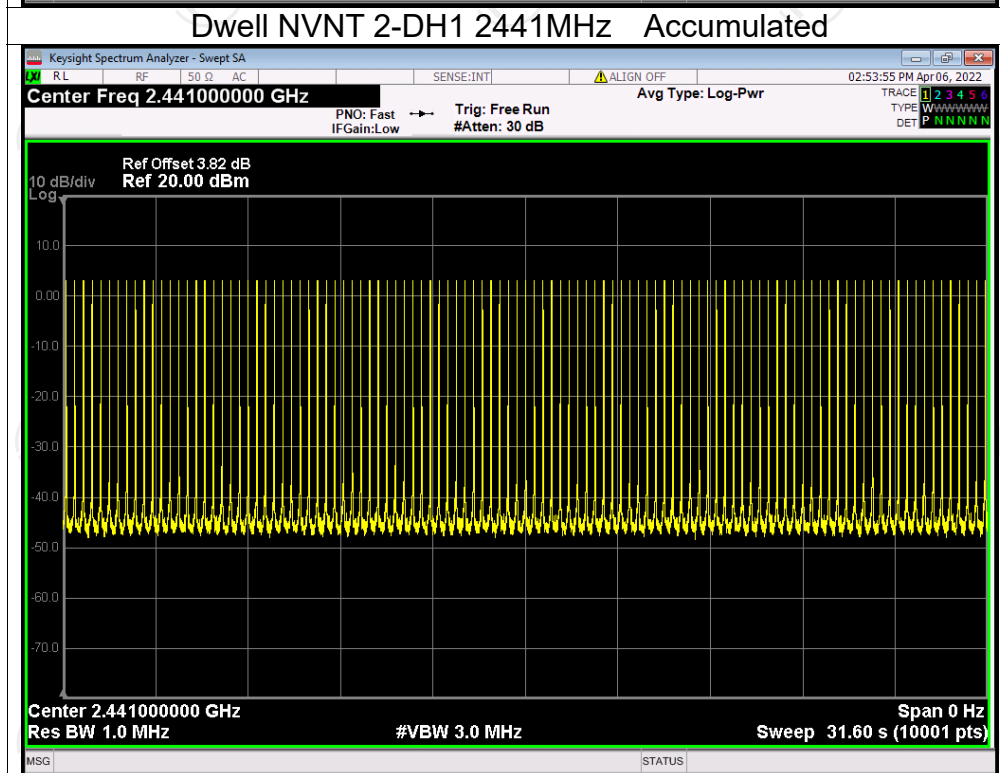
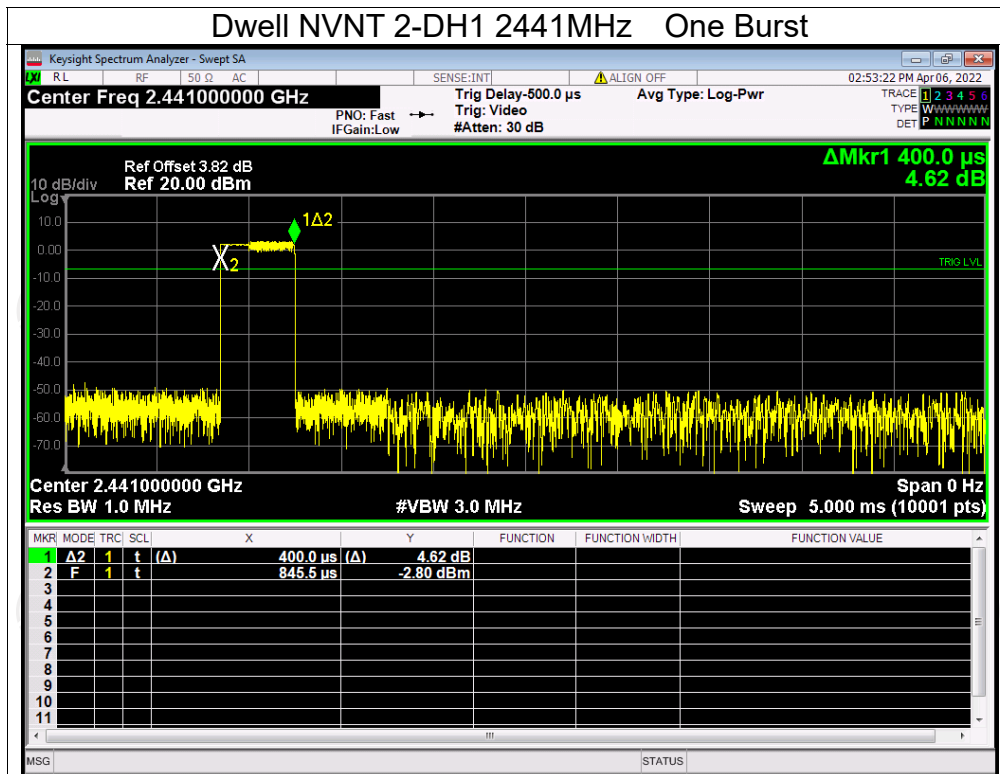


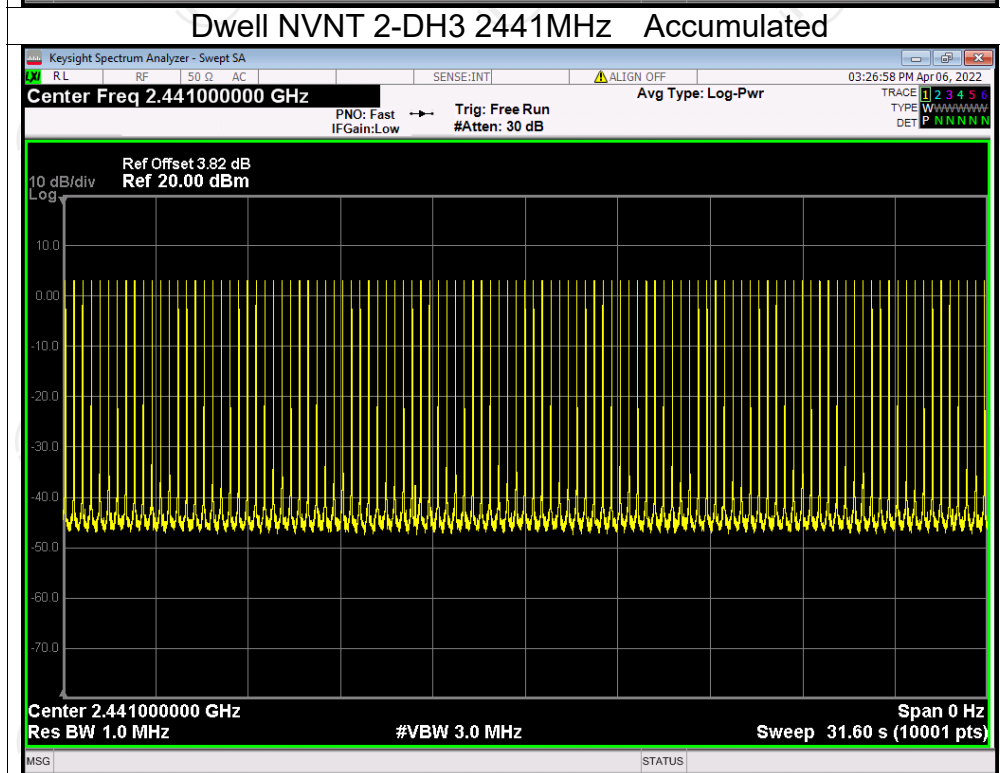
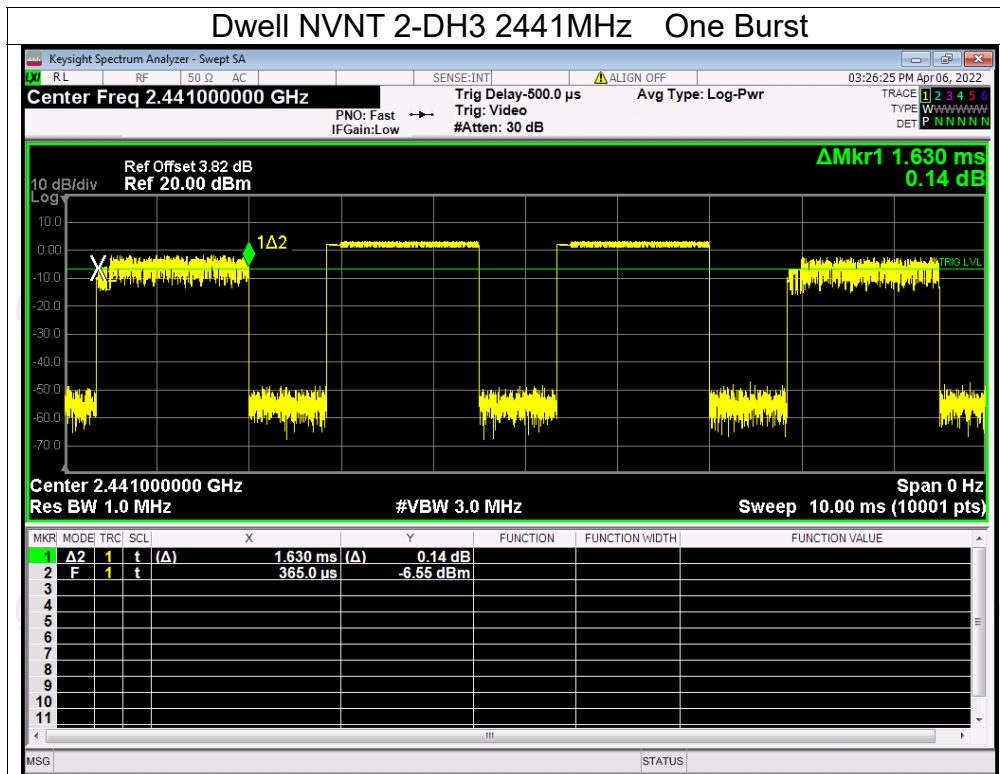
Dwell NVNT 1-DH1 2441MHz Accumulated

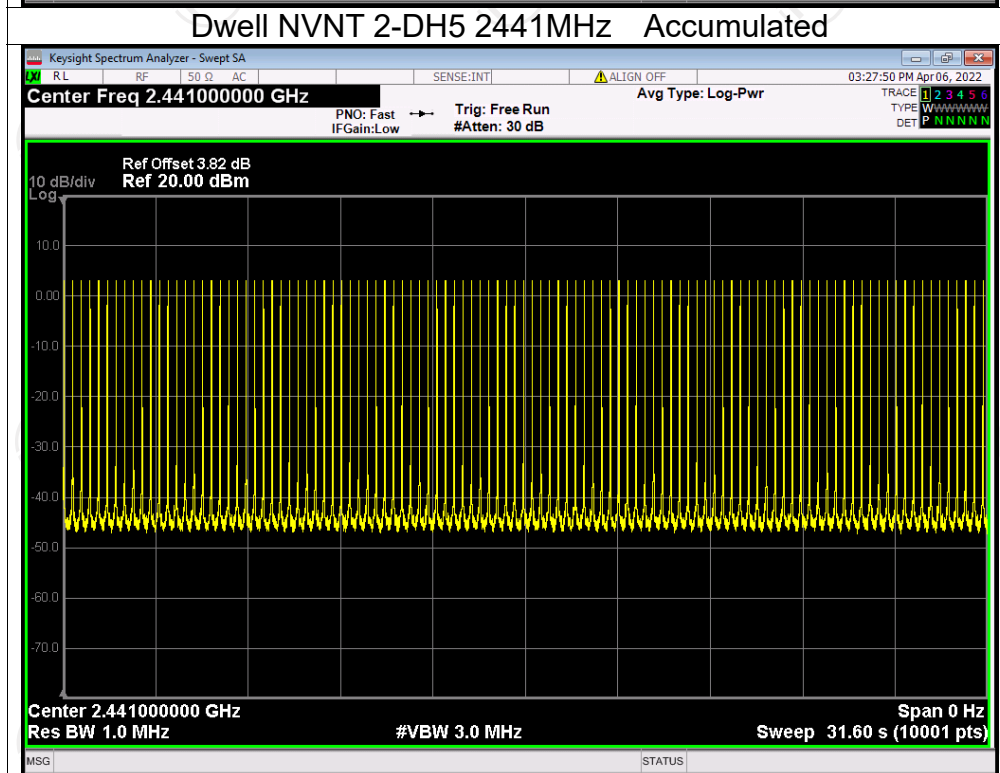
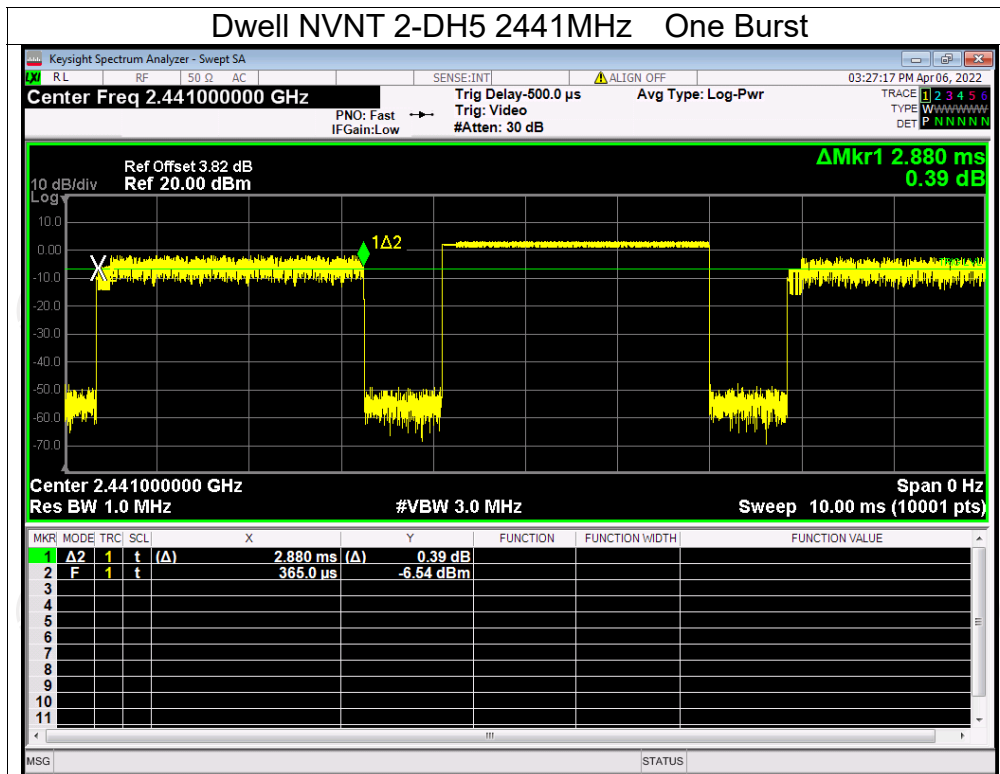


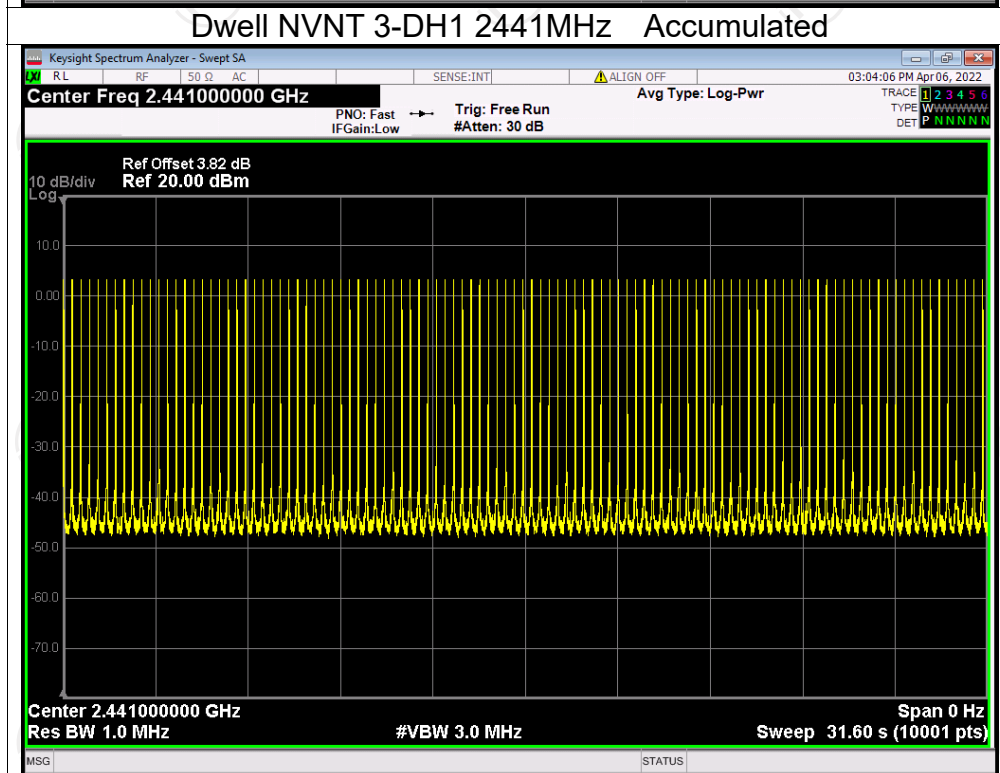
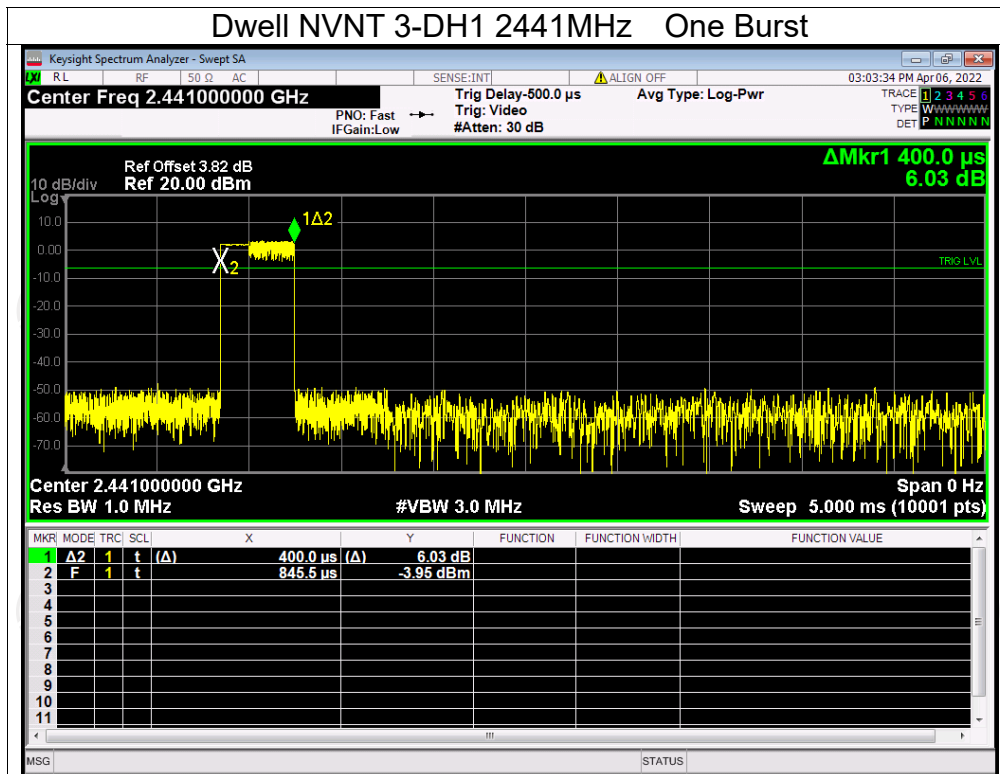


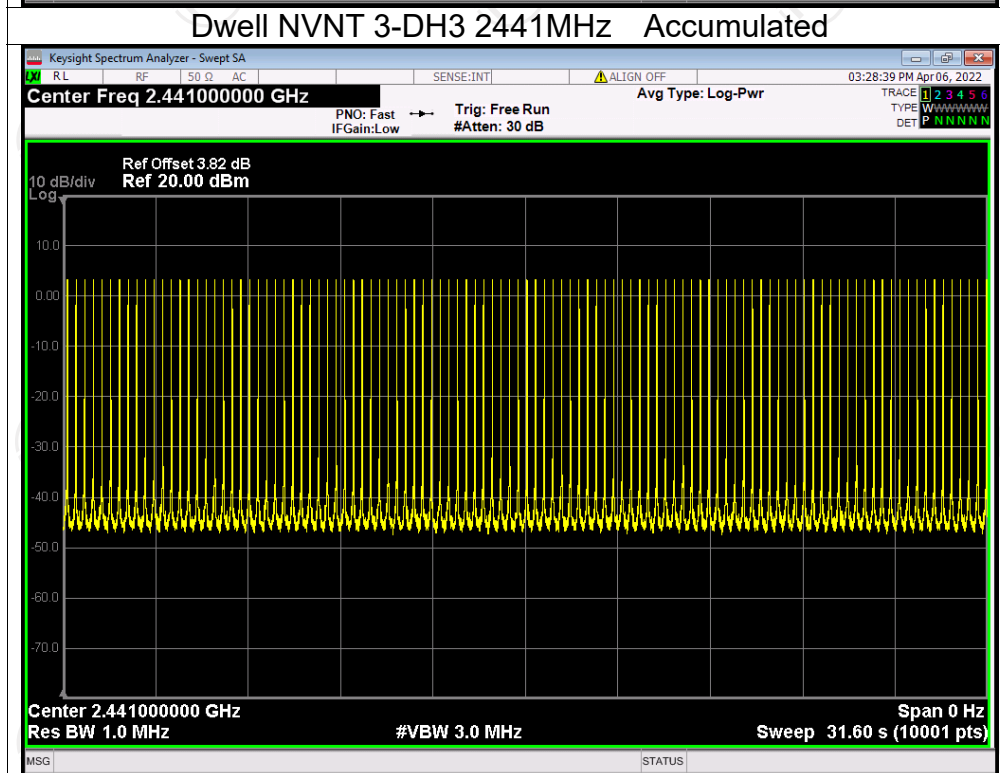
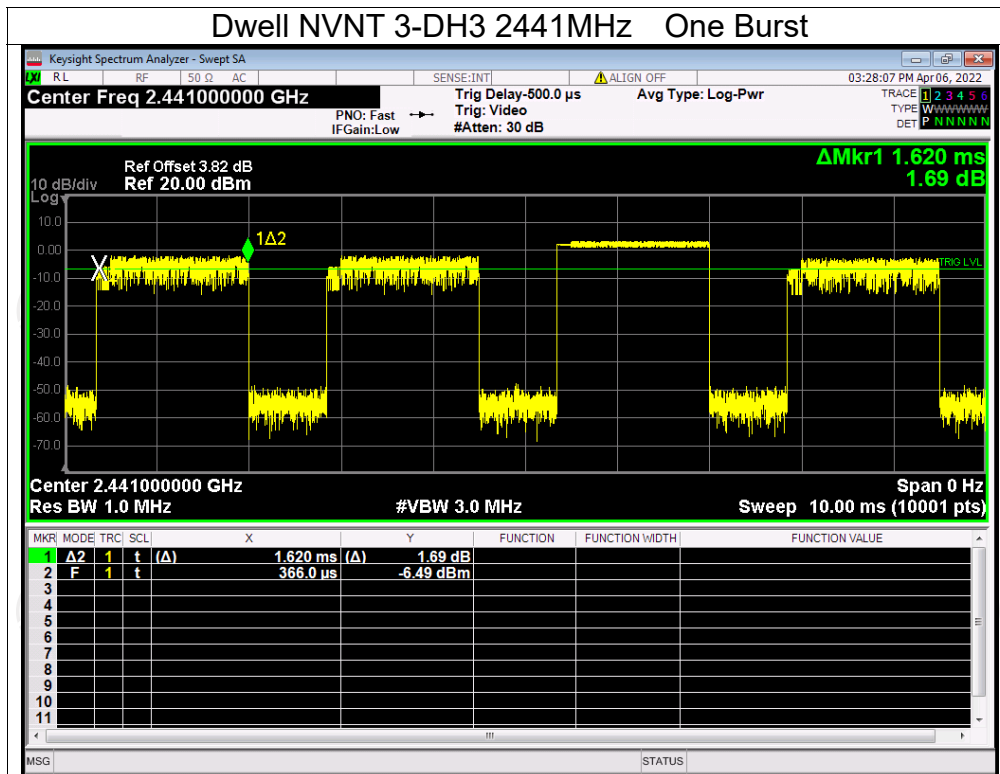


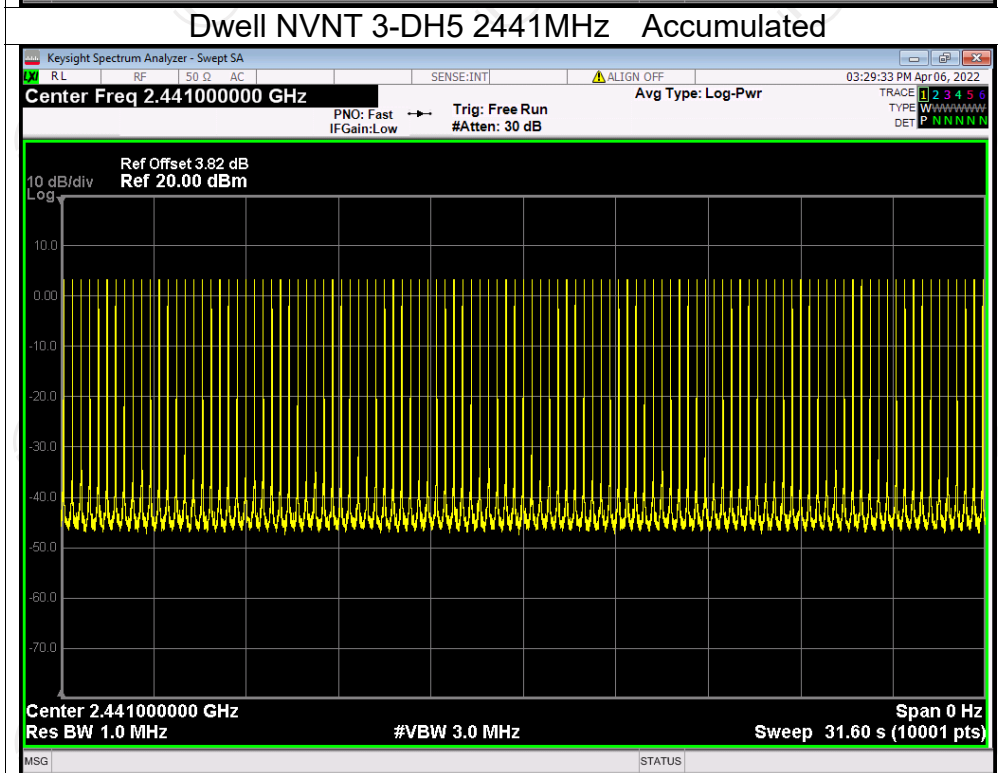
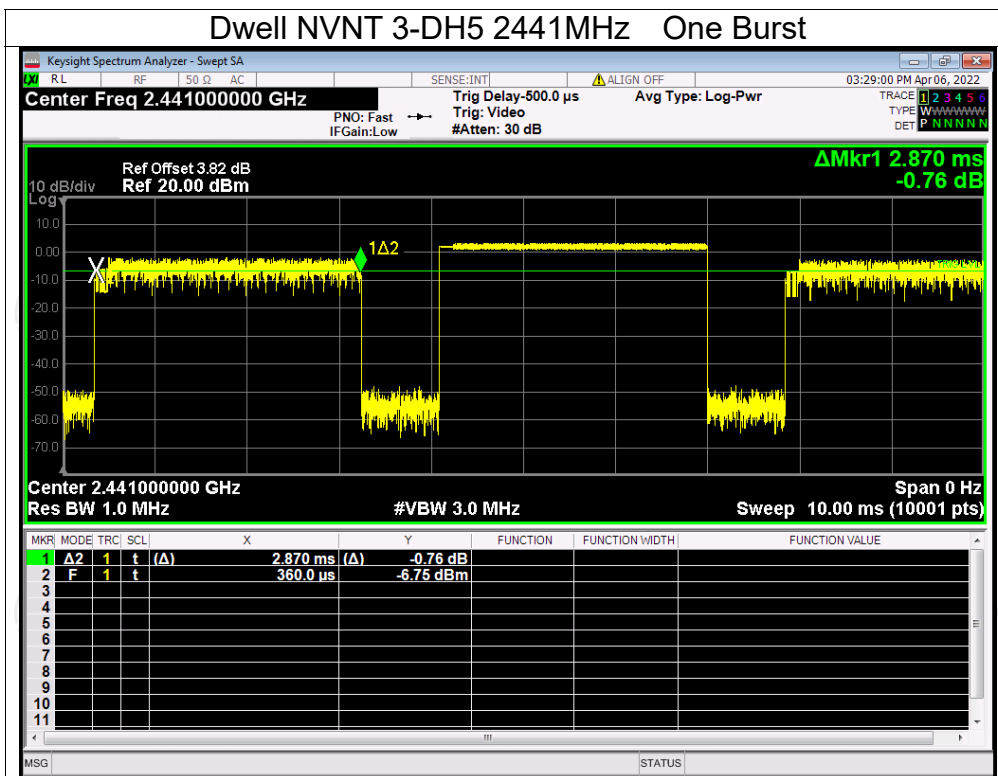










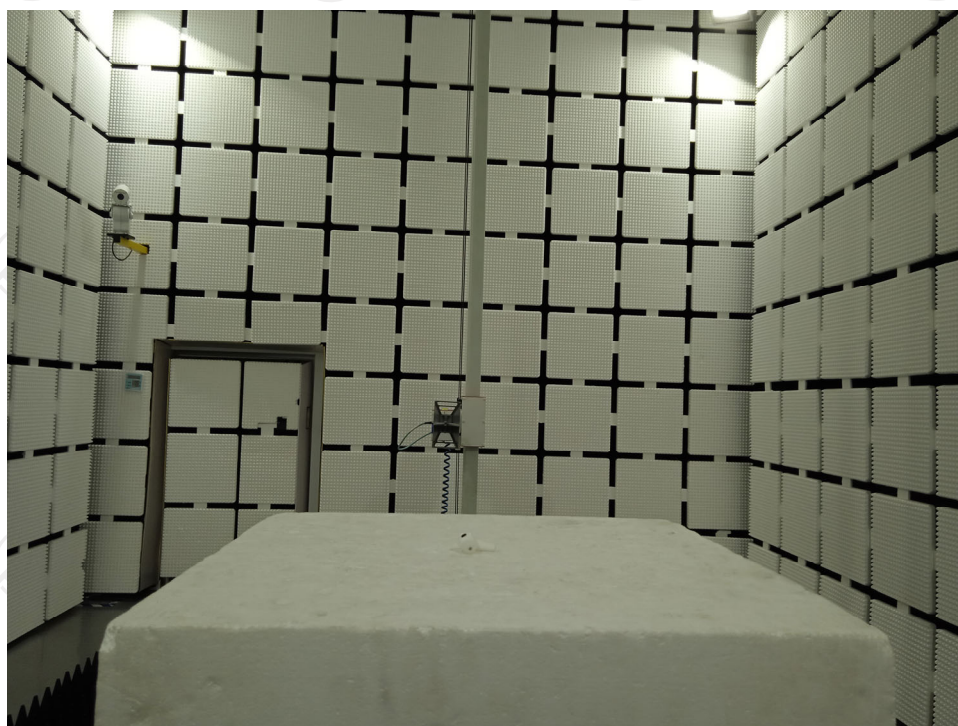
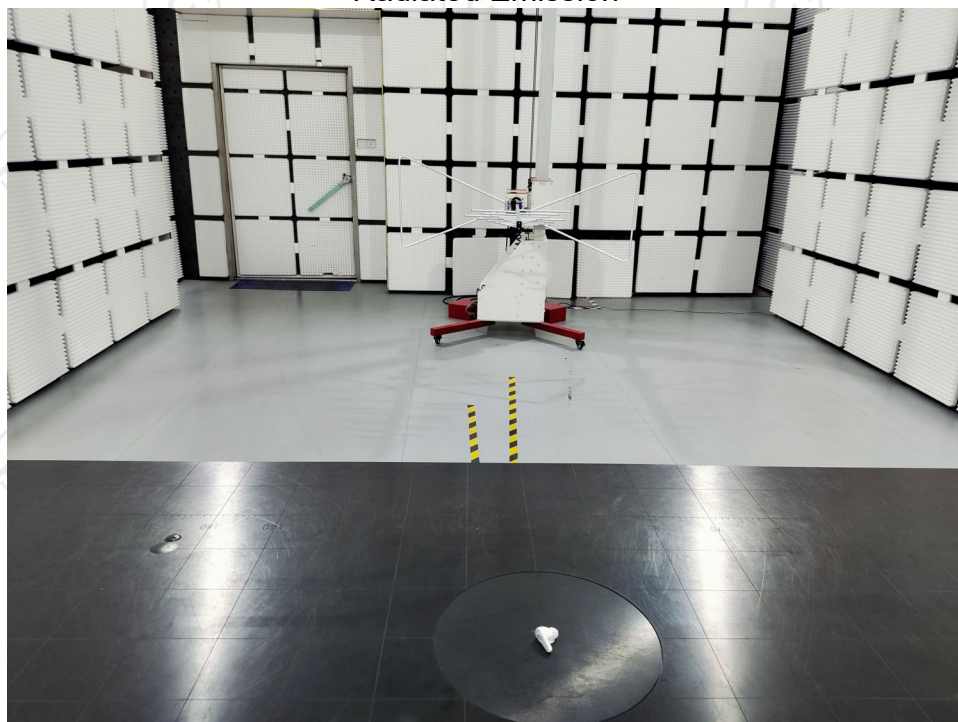


Appendix B: Photographs of Test Setup

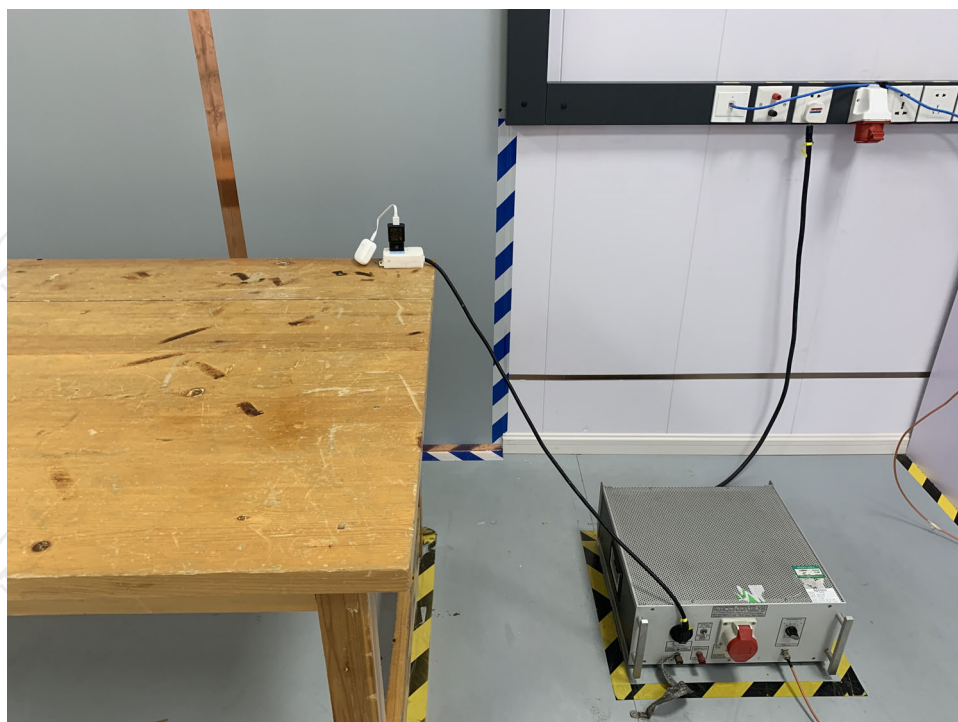
Product: TWS Game headset

Model: X2

Radiated Emission



Conducted Emission



Appendix C: Photographs of EUT

Product: TWS Game headset

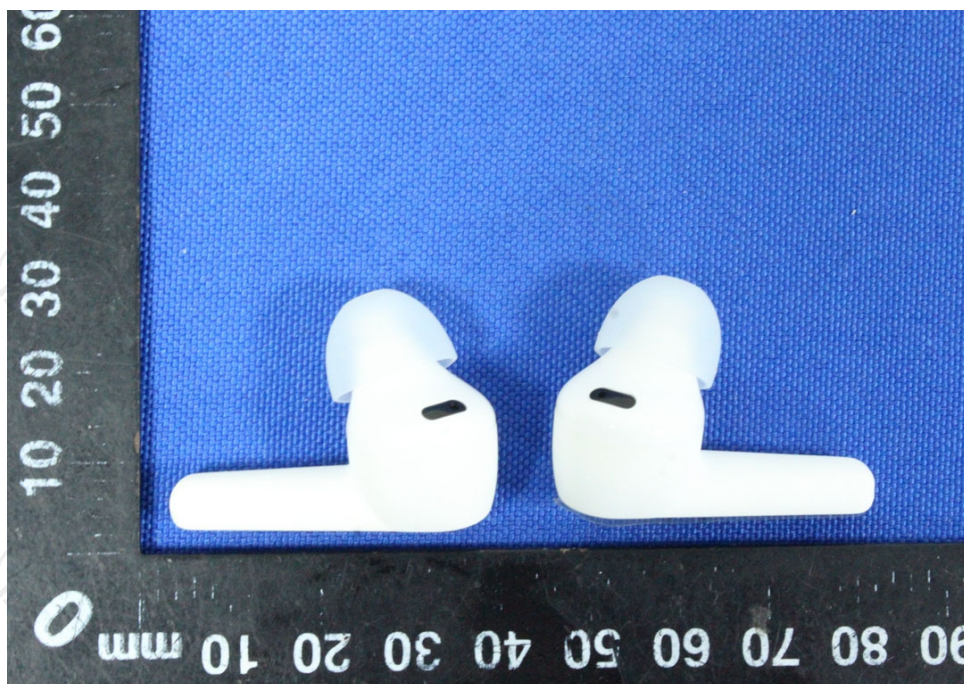
Model: X2

External Photos





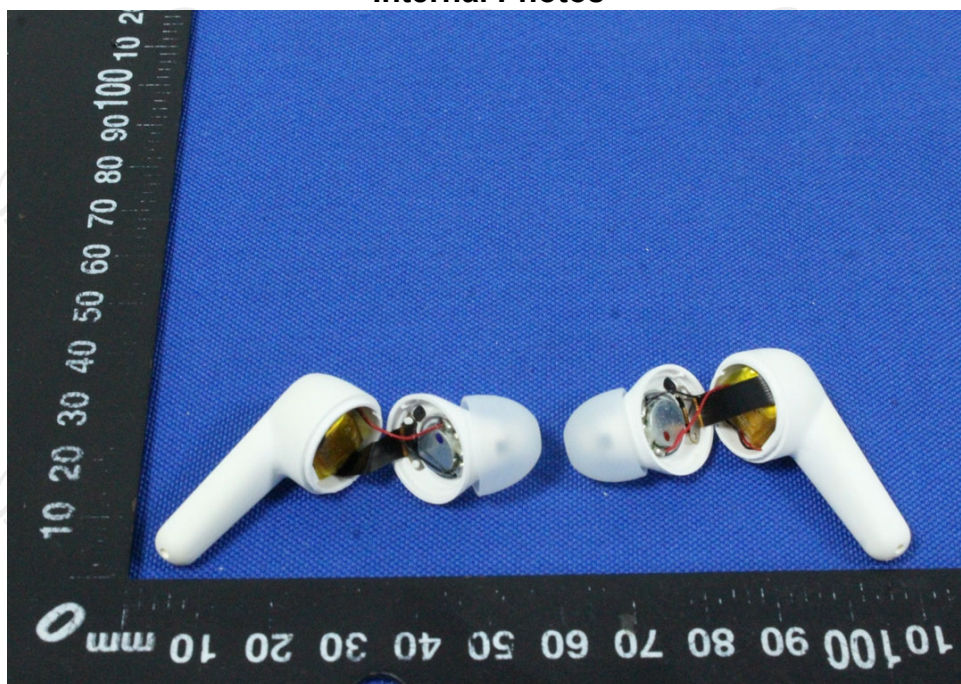


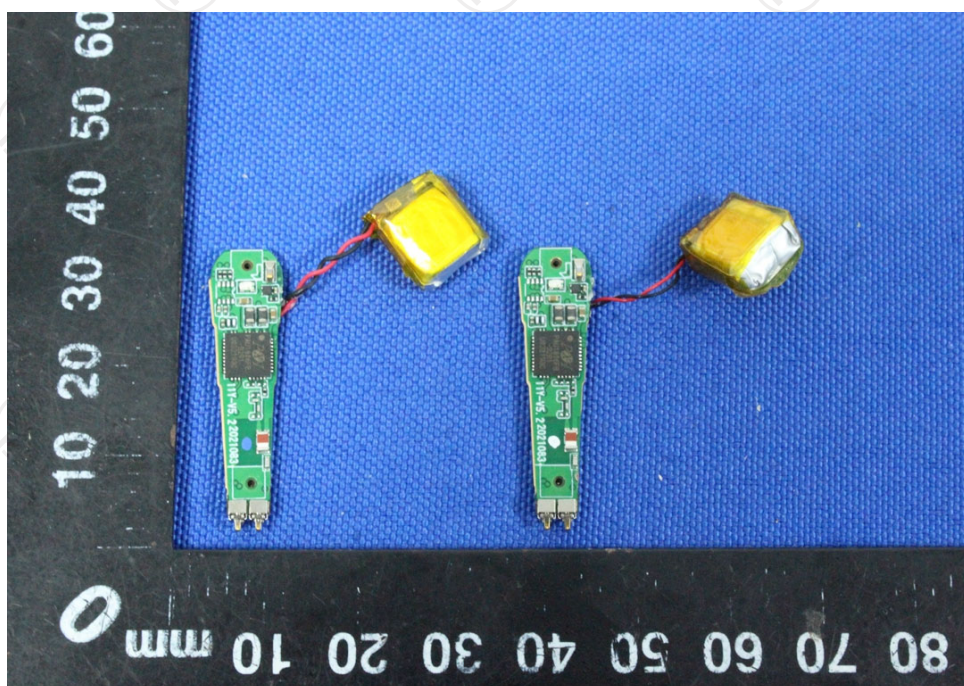
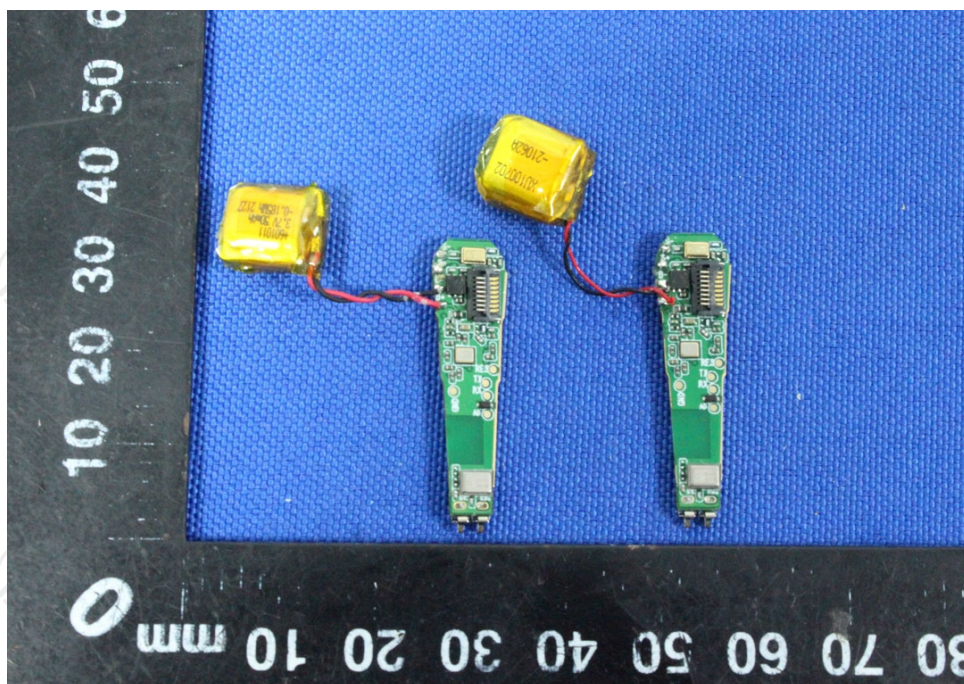


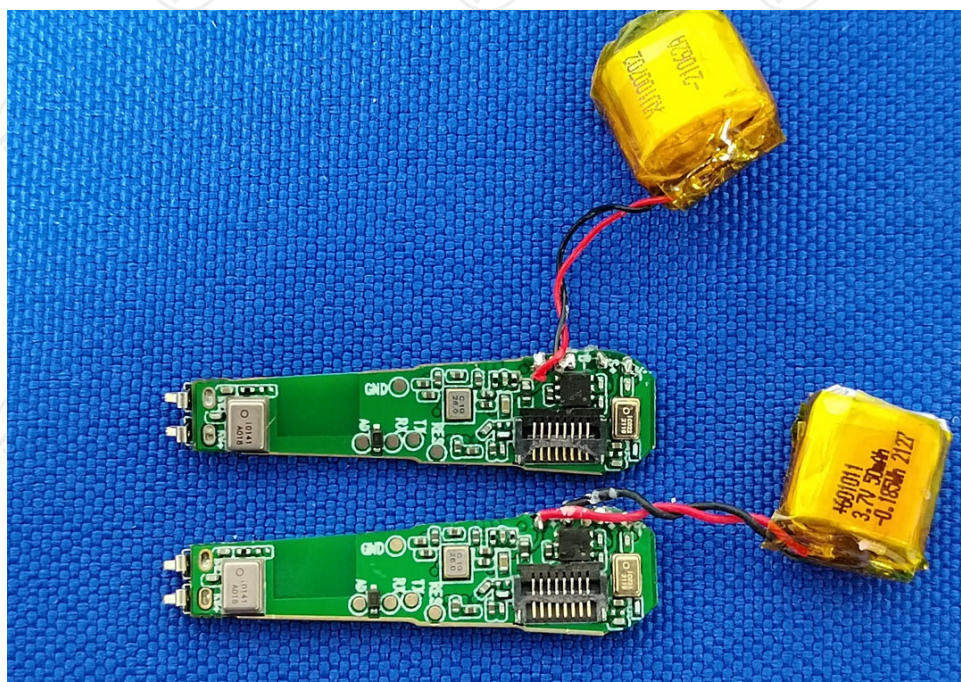
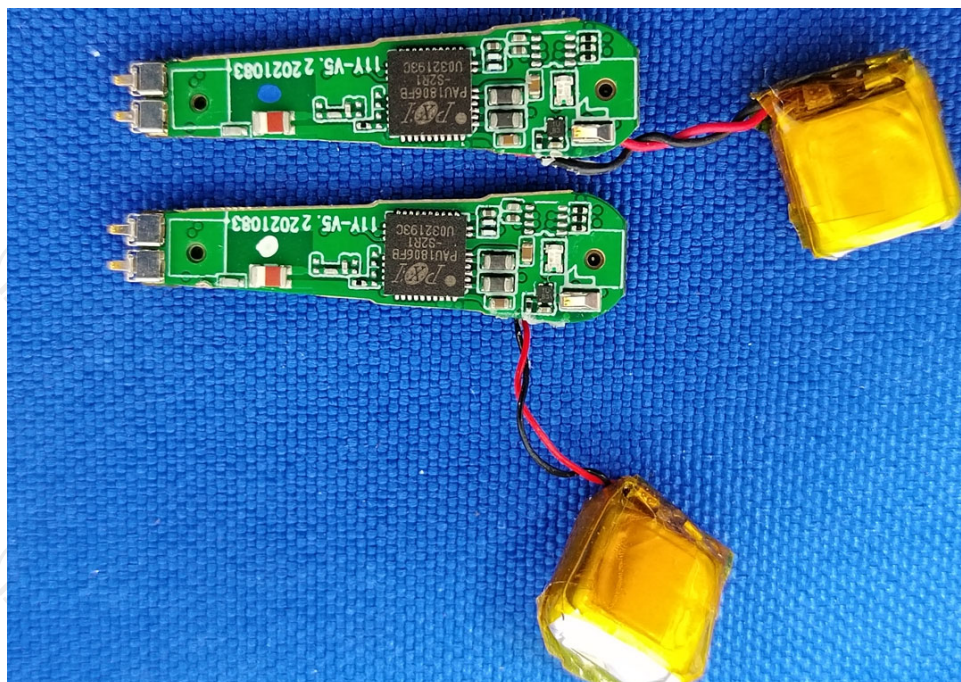




Product: TWS Game headset
Model: X2
Internal Photos







*****END OF REPORT*****